

<b>Notice of References Cited</b>	Application/Control No. 10/587,012		Applicant(s)/Patent Under Reexamination FONTIJN, WILLEM	
	Examiner DUC M. NGUYEN		Art Unit 2618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,407,107	08-2008	Engestrom et al.	235/472.01
*	B	US-6,925,287	08-2005	Davie et al.	455/41.1
*	C	US-2004/0002305	01-2004	Byman-Kivivuori et al.	455/41.2
*	D	US-2005/0082367	04-2005	Jalkanen et al.	235/451
*	E	US-2004/0176032	09-2004	Kotola et al.	455/041.2
*	F	US-5,850,187	12-1998	Carrender et al.	340/10.6
*	G	US-7,190,257	03-2007	Maltseff et al.	340/10.51
*	H	US-7,107,009	09-2006	Sairanen et al.	455/41.1
*	I	US-7,359,714	04-2008	Parupudi et al.	455/456.1
*	J	US-5,642,303	06-1997	Small et al.	708/109
*	K	US-6,201,973	03-2001	Kowaguchi, Satoshi	455/456.6
*	L	US-6,633,759	10-2003	Kobayashi, Koichi	455/419
*	M	US-4,725,841	02-1988	Nysen et al.	342/44

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.